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|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/549,485 | | Applicant(s)/Patent Under Reexamination RUDDUCK ET AL. | |
| | Examiner William L. Miller | | Art Unit 3677 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-7,337,944 | 03-2008 | Devar, Rodney C. | 232/19 |
| * | B | US-6,028,517 | 02-2000 | Sansone et al. | 340/569 |
| * | C | US-7,256,691 | 08-2007 | Awobue, Christopher | 340/545.6 |
| * | D | US-5,774,053 | 06-1998 | Porter, David | 340/568.1 |
| * | E | US-5,850,967 | 12-1998 | White, J. La Nell | 232/17 |
| * | F | US-6,995,671 | 02-2006 | Dutta et al. | 340/569 |
| * | G | US-2001/0045449 | 11-2001 | Shannon, Bruce L. | 232/19 |
| * | H | US-2005/0172462 | 08-2005 | Rudduck et al. | 024/606 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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